

# SSM3K62TU

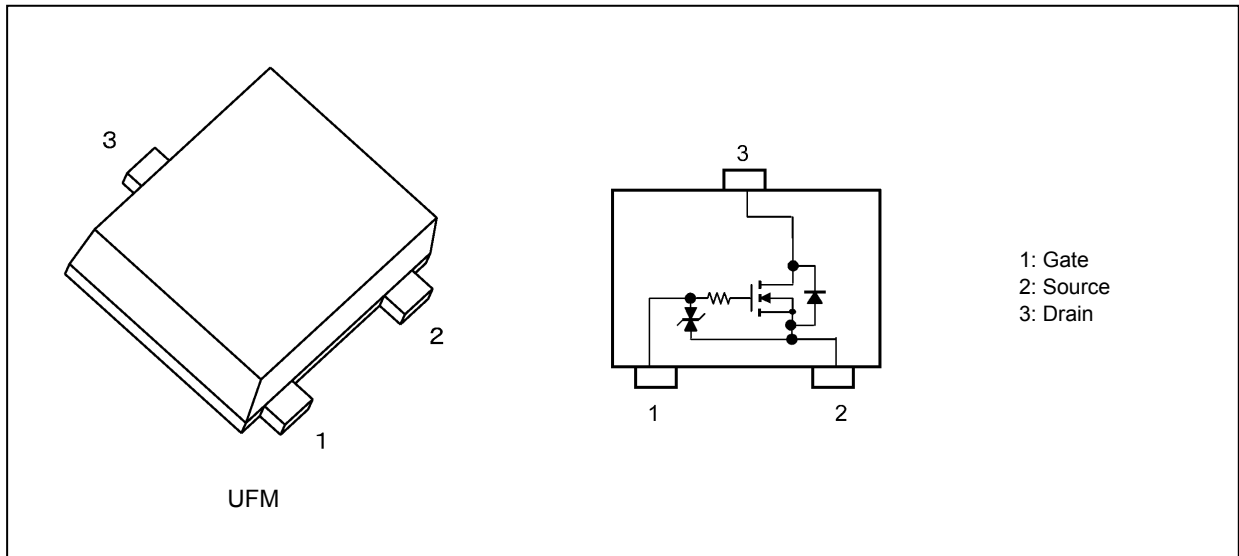
## 1. Applications

- Power Management Switches
- DC-DC Converters

## 2. Features

- (1) 1.2-V drive
- (2) Low drain-source on-resistance
  - :  $R_{DS(ON)} = 43 \text{ m}\Omega$  (typ.) (@ $V_{GS} = 4.5 \text{ V}$ )
  - $R_{DS(ON)} = 50 \text{ m}\Omega$  (typ.) (@ $V_{GS} = 2.5 \text{ V}$ )
  - $R_{DS(ON)} = 60 \text{ m}\Omega$  (typ.) (@ $V_{GS} = 1.8 \text{ V}$ )
  - $R_{DS(ON)} = 70 \text{ m}\Omega$  (typ.) (@ $V_{GS} = 1.5 \text{ V}$ )
  - $R_{DS(ON)} = 98 \text{ m}\Omega$  (typ.) (@ $V_{GS} = 1.2 \text{ V}$ )

## 3. Packaging and Pin Assignment



Start of commercial production

2016-08

**4. Absolute Maximum Ratings (Note) (Unless otherwise specified, T<sub>a</sub> = 25 °C)**

Characteristics	Symbol	Rating	Unit
Drain-source voltage	V <sub>DSS</sub>	20	V
Gate-source voltage	V <sub>GSS</sub>	±8	
Drain current (DC) (Note 1)	I <sub>D</sub>	0.8	A
Drain current (pulsed) (Note 1), (Note 2)	I <sub>DP</sub>	1.6	
Power dissipation (Note 3)	P <sub>D</sub>	500	mW
Power dissipation t ≤ 10s (Note 3)	P <sub>D</sub>	1000	mW
Channel temperature	T <sub>ch</sub>	150	°C
Storage temperature	T <sub>stg</sub>	-55 to 150	°C

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2: Pulse width (PW) ≤ 10 s, duty ≤ 1%

Note 3: Device mounted on an FR4 board. (PD for the entire IC)  
(FR4, 25.4 mm × 25.4 mm × 1.6 mm, Cu pad: 645 mm<sup>2</sup>)

Note: The MOSFETs in this device are sensitive to electrostatic discharge. When handling this device, the worktables, operators, soldering irons and other objects should be protected against anti-static discharge.

Note: The channel-to-ambient thermal resistance, R<sub>th(ch-a)</sub>, and the drain power dissipation, P<sub>D</sub>, vary according to the board material, board area, board thickness and pad area. When using this device, be sure to take heat dissipation fully into account.

**5. Electrical Characteristics**

**5.1. Static Characteristics (Unless otherwise specified,  $T_a = 25\text{ }^\circ\text{C}$ )**

Characteristics	Symbol	Test Condition	Min	Typ.	Max	Unit
Gate leakage current	$I_{GSS}$	$V_{DS} = 0\text{ V}, V_{GS} = \pm 8\text{ V}$	—	—	$\pm 10$	$\mu\text{A}$
Drain cut-off current	$I_{DSS}$	$V_{DS} = 10\text{ V}, V_{GS} = 0\text{ V}$	—	—	1	
Drain-source breakdown voltage	$V_{(BR)DSS}$	$I_D = 1\text{ mA}, V_{GS} = 0\text{ V}$	20	—	—	V
Drain-source breakdown voltage (Note 1)	$V_{(BR)DSX}$	$I_D = 1\text{ mA}, V_{GS} = -5\text{ V}$	15	—	—	
Gate threshold voltage (Note 2)	$V_{th}$	$V_{DS} = 3\text{ V}, I_D = 1\text{ mA}$	0.4	0.6	1.0	
Drain-source on-resistance (Note 3)	$R_{DS(ON)}$	$I_D = 100\text{ mA}, V_{GS} = 1.2\text{ V}$	—	98	432	$\text{m}\Omega$
		$I_D = 200\text{ mA}, V_{GS} = 1.5\text{ V}$	—	70	139	
		$I_D = 600\text{ mA}, V_{GS} = 1.8\text{ V}$	—	60	89	
		$I_D = 800\text{ mA}, V_{GS} = 2.5\text{ V}$	—	50	68	
		$I_D = 800\text{ mA}, V_{GS} = 4.5\text{ V}$	—	43	57	
Forward transfer admittance (Note 3)	$ Y_{fs} $	$V_{DS} = 3\text{ V}, I_D = 200\text{ mA}$	—	3.0	—	S

Note 1: If a reverse bias is applied between gate and source, this device enters  $V_{(BR)DSX}$  mode. Note that the drain-source breakdown voltage is lowered in this mode.

Note 2: Let  $V_{th}$  be the voltage applied between gate and source that causes the drain current ( $I_D$ ) to below (1 mA for this device). Then, for normal switching operation,  $V_{GS(ON)}$  must be higher than  $V_{th}$ , and  $V_{GS(OFF)}$  must be lower than  $V_{th}$ . This relationship can be expressed as:  $V_{GS(OFF)} < V_{th} < V_{GS(ON)}$ . Take this into consideration when using the device.

Note 3: Pulse measurement.

**5.2. Dynamic Characteristics (Unless otherwise specified,  $T_a = 25\text{ }^\circ\text{C}$ )**

Characteristics	Symbol	Test Condition	Min	Typ.	Max	Unit
Input capacitance	$C_{iss}$	$V_{DS} = 10\text{ V}, V_{GS} = 0\text{ V}, f = 1\text{ MHz}$	—	177	—	pF
Reverse transfer capacitance	$C_{rss}$		—	17	—	
Output capacitance	$C_{oss}$		—	52	—	
Switching time (turn-on time)	$t_{on}$	$V_{DD} = 10\text{ V}, I_D = 800\text{ mA}, V_{GS} = 0\text{ to }4.5\text{ V}, R_G = 50\ \Omega$	—	332	—	ns
Switching time (turn-off time)	$t_{off}$		—	2653	—	

**5.3. Switching Time Test Circuit**

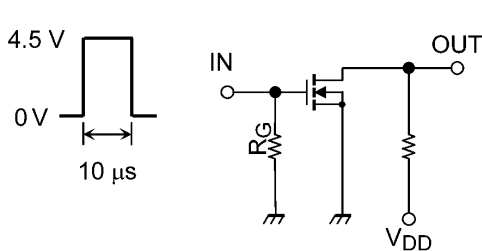


Fig. 5.3.1 Switching Time Test Circuit

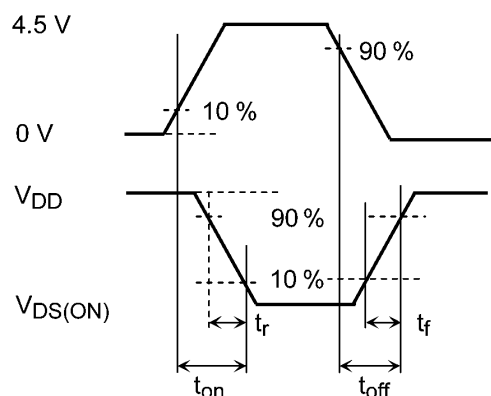


Fig. 5.3.2 Input Waveform/Output Waveform

**5.4. Gate Charge Characteristics (Unless otherwise specified,  $T_a = 25\text{ }^\circ\text{C}$ )**

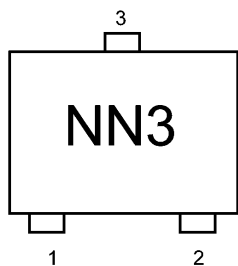
Characteristics	Symbol	Test Condition	Min	Typ.	Max	Unit
Total gate charge (gate-source plus gate-drain)	$Q_g$	$V_{DD} = 10\text{ V}, I_D = 800\text{ mA}, V_{GS} = 4.5\text{ V}$	—	2.0	—	nC
Gate-source charge 1	$Q_{gs1}$		—	1.3	—	
Gate-drain charge	$Q_{gd}$		—	0.6	—	

**5.5. Source-Drain Characteristics (Unless otherwise specified,  $T_a = 25\text{ }^\circ\text{C}$ )**

Characteristics	Symbol	Test Condition	Min	Typ.	Max	Unit
Diode forward voltage (Note 1)	$V_{DSF}$	$I_D = -800\text{ mA}, V_{GS} = 0\text{ V}$	—	-0.6	-1.2	V

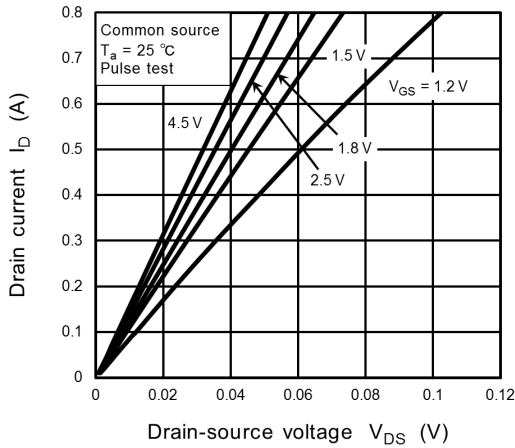
Note 1: Pulse measurement.

**6. Marking**

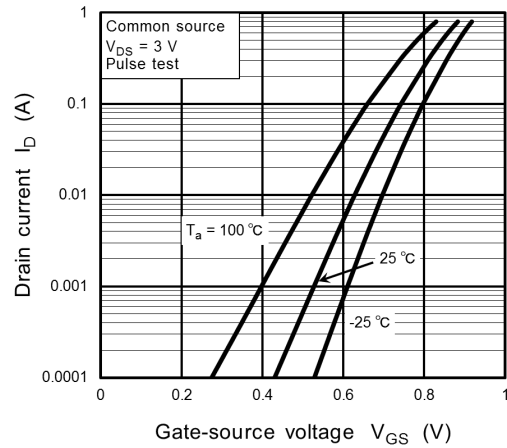


**Fig. 6.1 Marking**

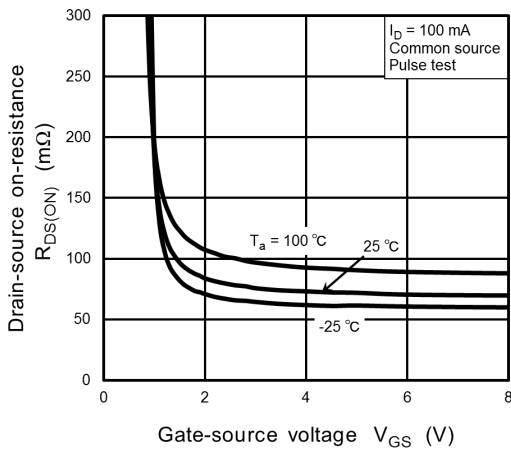
**7. Characteristics Curves (Note)**



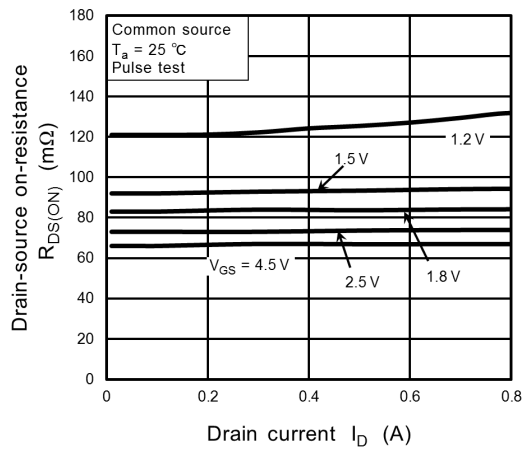
**Fig. 7.1  $I_D - V_{DS}$**



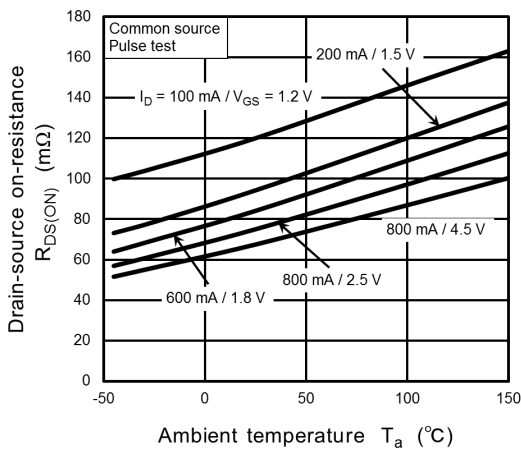
**Fig. 7.2  $I_D - V_{GS}$**



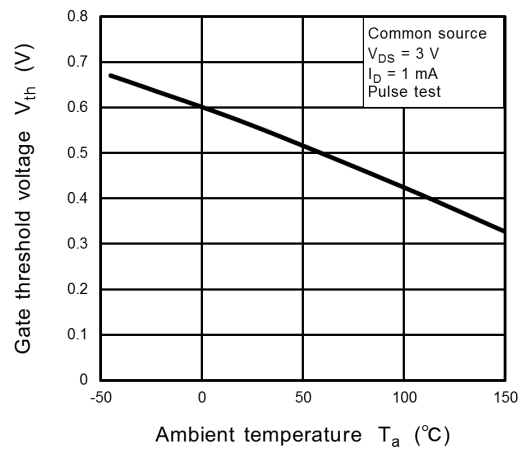
**Fig. 7.3  $R_{DS(ON)} - V_{GS}$**



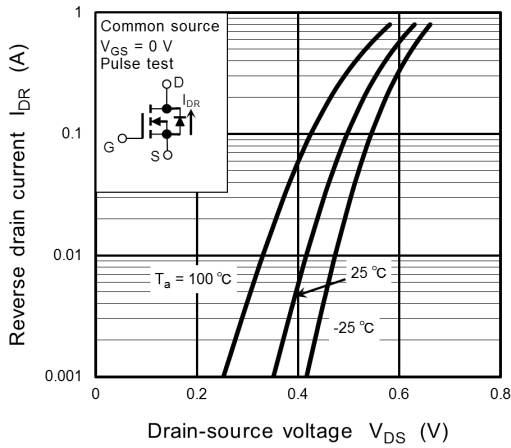
**Fig. 7.4  $R_{DS(ON)} - I_D$**



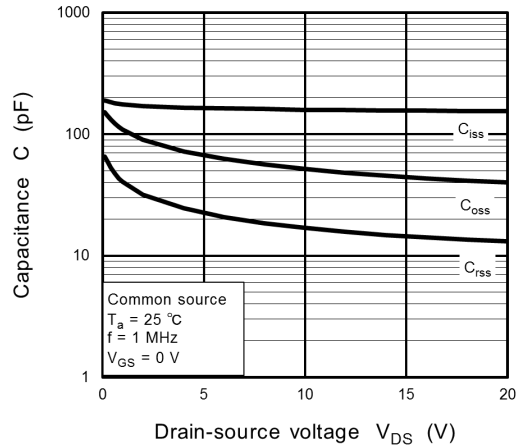
**Fig. 7.5  $R_{DS(ON)} - T_a$**



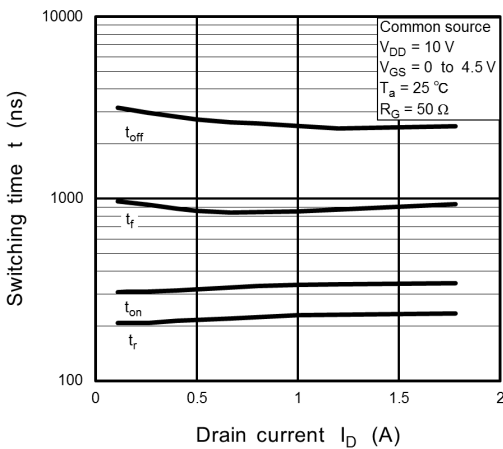
**Fig. 7.6  $V_{th} - T_a$**



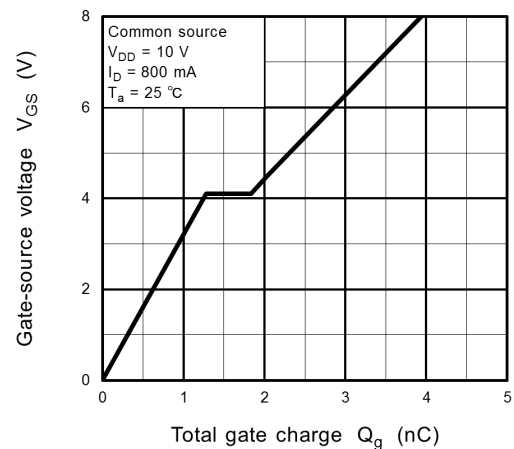
**Fig. 7.7  $I_{DR} - V_{DS}$**



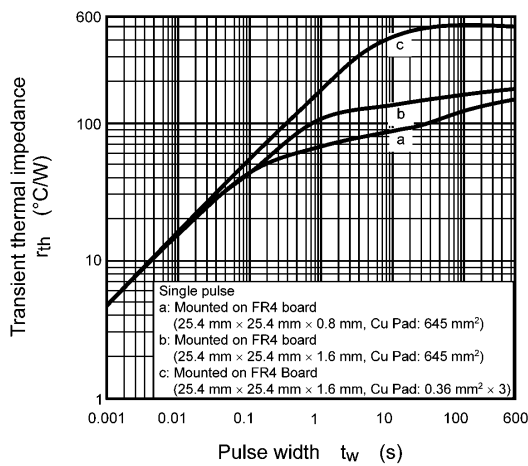
**Fig. 7.8  $C - V_{DS}$**



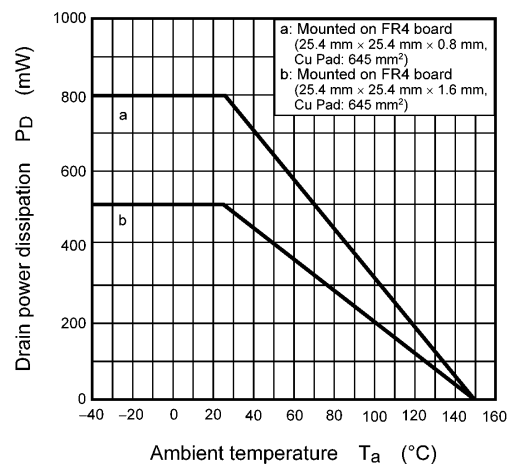
**Fig. 7.9  $t - I_D$**



**Fig. 7.10 Dynamic Input Characteristics**



**Fig. 7.11  $r_{th} - t_w$**

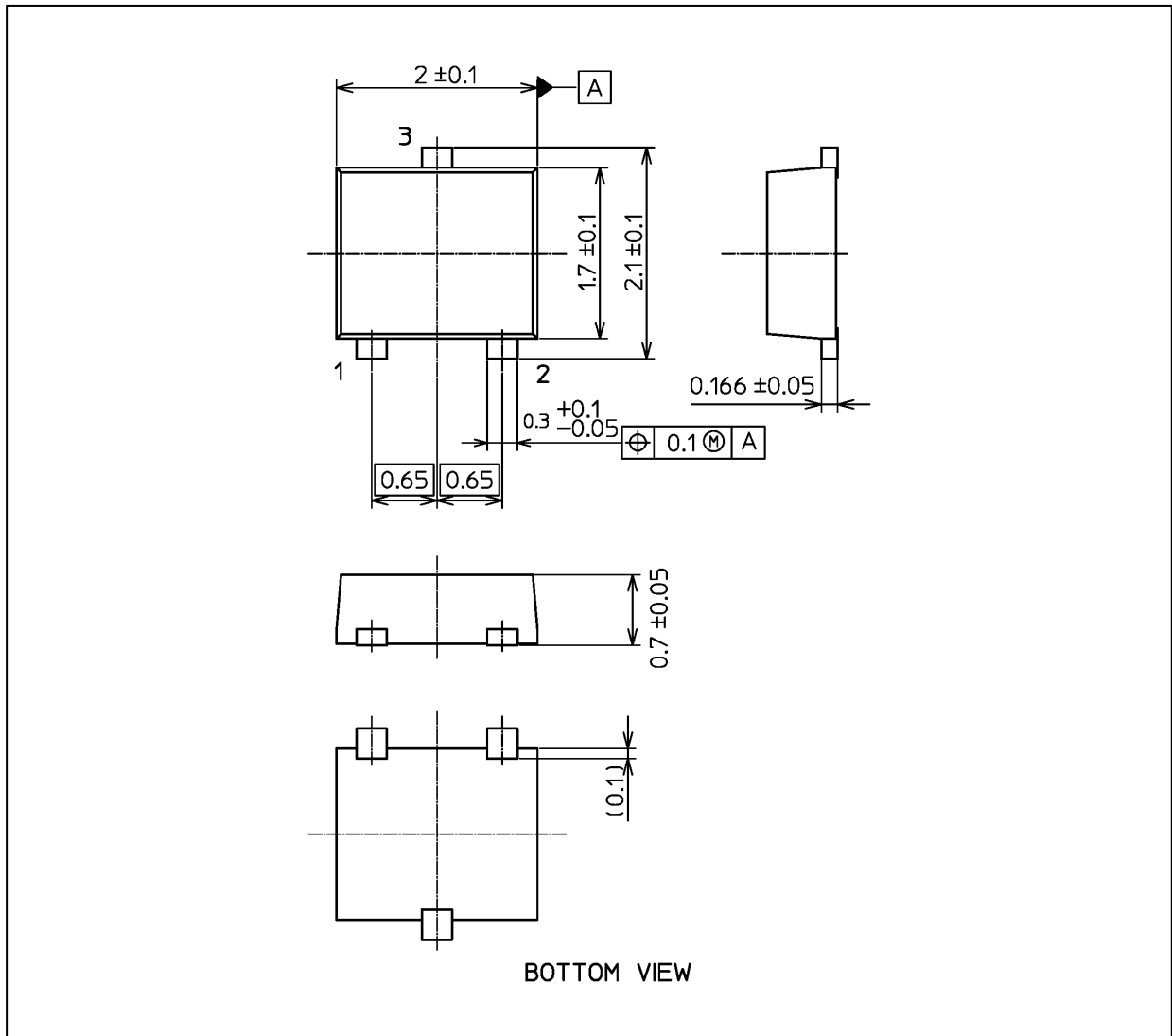


**Fig. 7.12  $P_D - T_a$**

Note: The above characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.

Package Dimensions

Unit: mm



Weight: 6.6 mg (typ.)

Package Name(s)
Nickname: UFM

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